

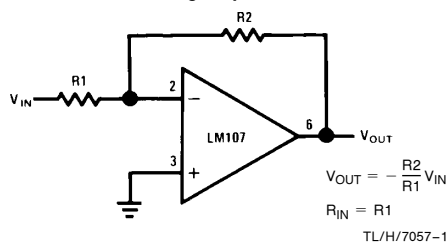
Op Amp Circuit Collection

National Semiconductor
Application Note 31
February 1978

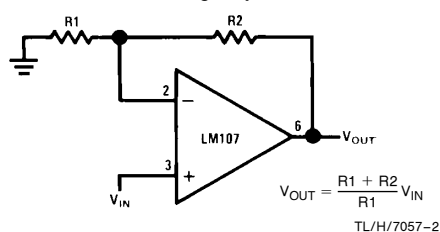


SECTION 1—BASIC CIRCUITS

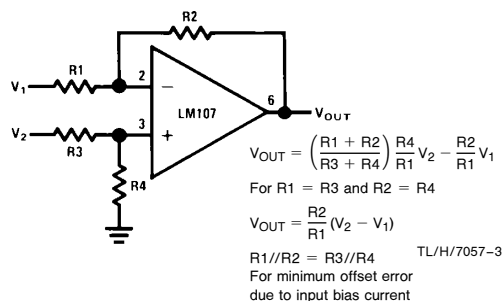
Inverting Amplifier



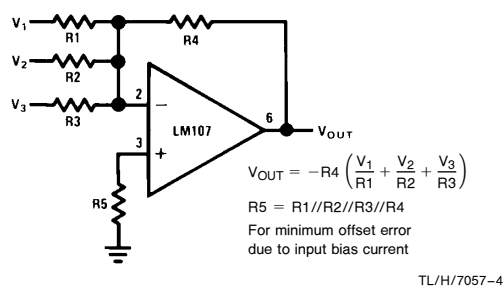
Non-Inverting Amplifier



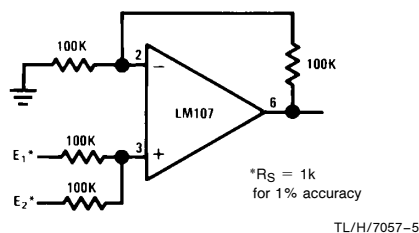
Difference Amplifier



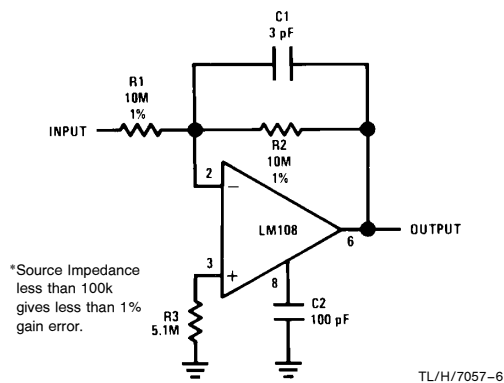
Inverting Summing Amplifier



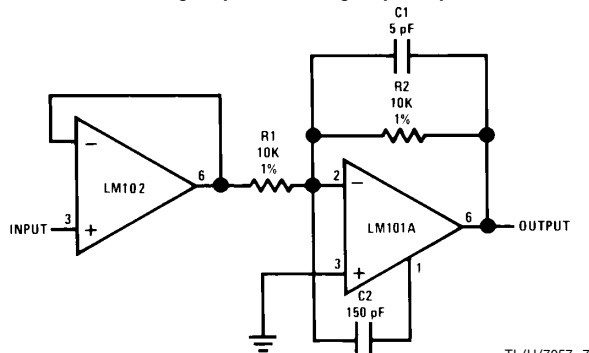
Non-Inverting Summing Amplifier



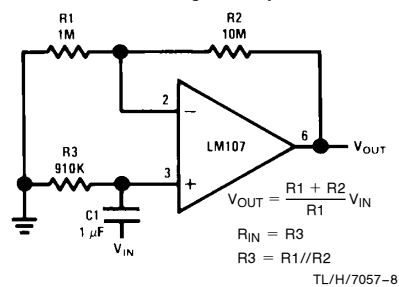
Inverting Amplifier with High Input Impedance



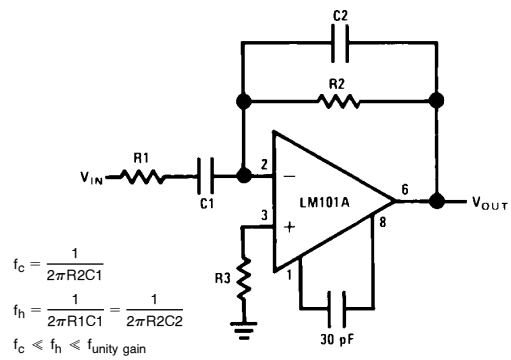
Fast Inverting Amplifier with High Input Impedance



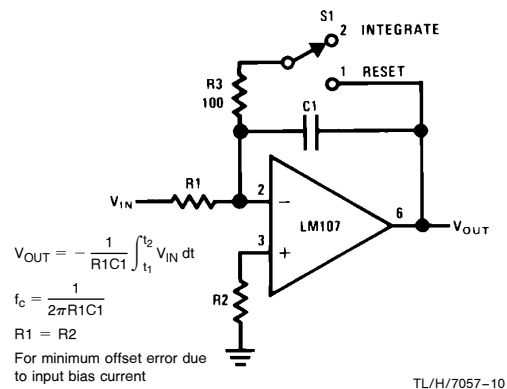
Non-Inverting AC Amplifier



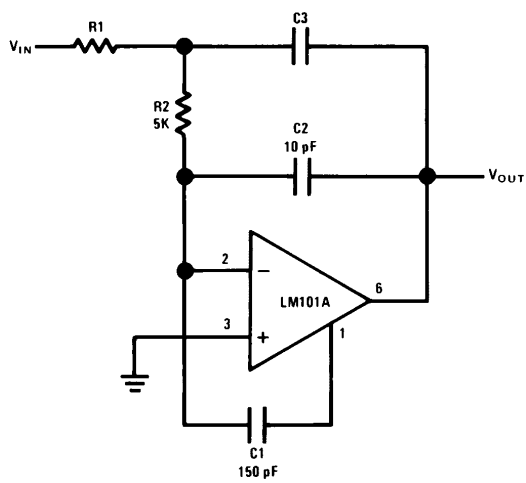
Practical Differentiator



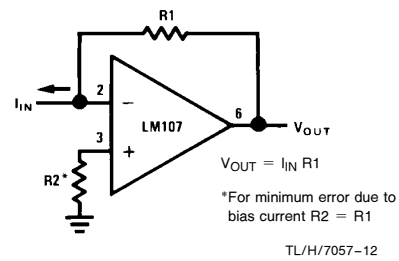
Integrator



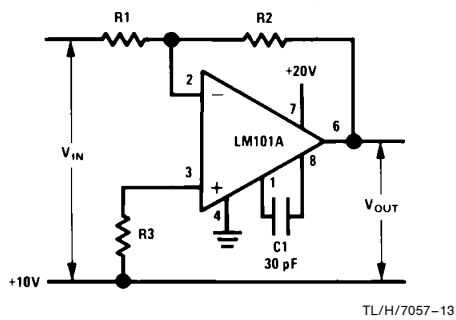
Fast Integrator



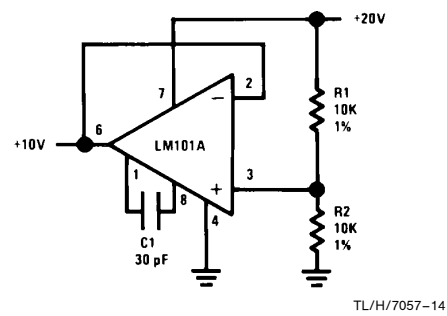
Current to Voltage Converter



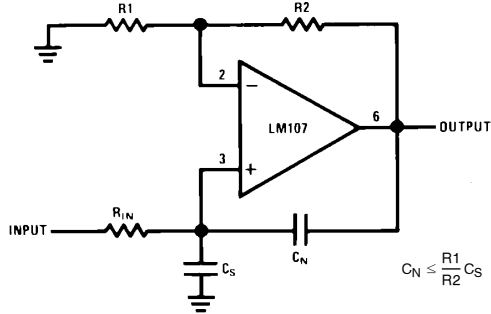
Circuit for Operating the LM101 without a Negative Supply



Circuit for Generating the Second Positive Voltage

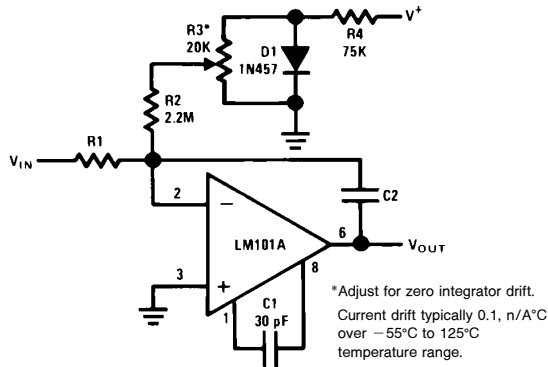


Neutralizing Input Capacitance to Optimize Response Time



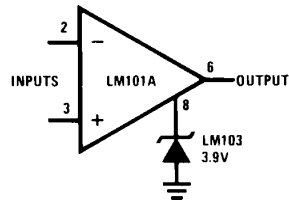
TL/H/7057-15

Integrator with Bias Current Compensation



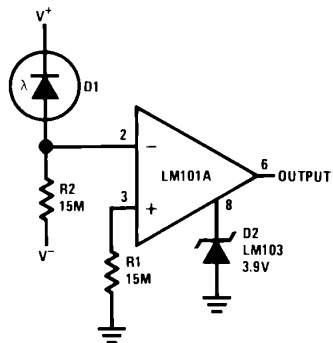
TL/H/7057-16

Voltage Comparator for Driving DTL or TTL Integrated Circuits



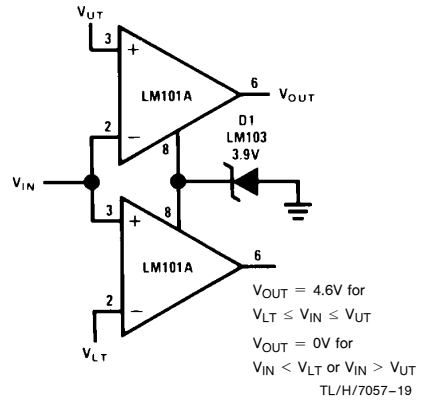
TL/H/7057-17

Threshold Detector for Photodiodes



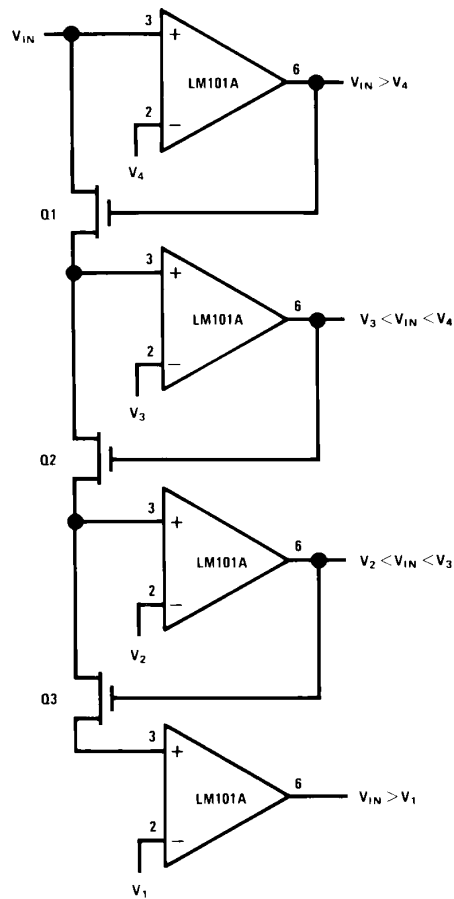
TL/H/7057-18

Double-Ended Limit Detector



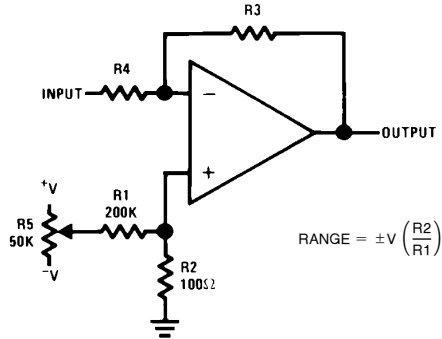
TL/H/7057-19

Multiple Aperture Window Discriminator



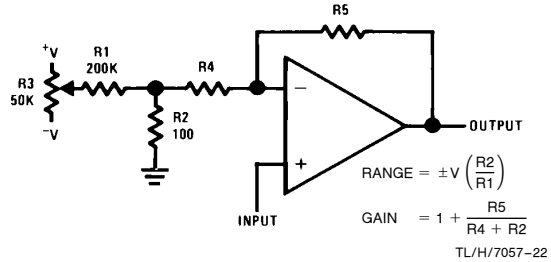
TL/H/7057-20

Offset Voltage Adjustment for Inverting Amplifiers Using Any Type of Feedback Element

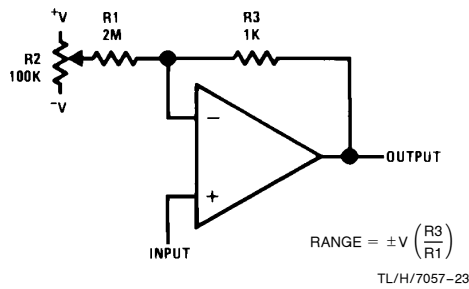


TL/H/7057-21

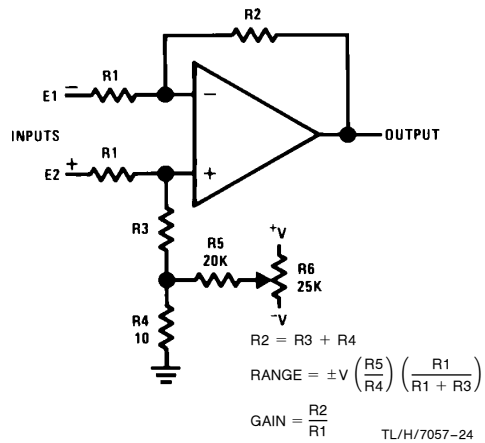
Offset Voltage Adjustment for Non-Inverting Amplifiers Using Any Type of Feedback Element



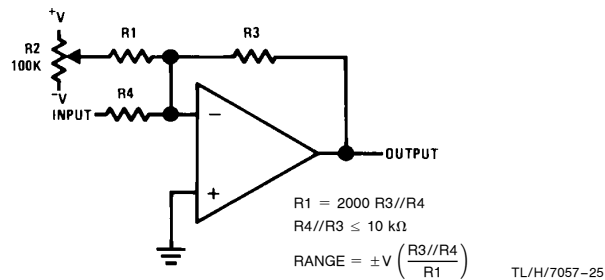
Offset Voltage Adjustment for Voltage Followers



Offset Voltage Adjustment for Differential Amplifiers

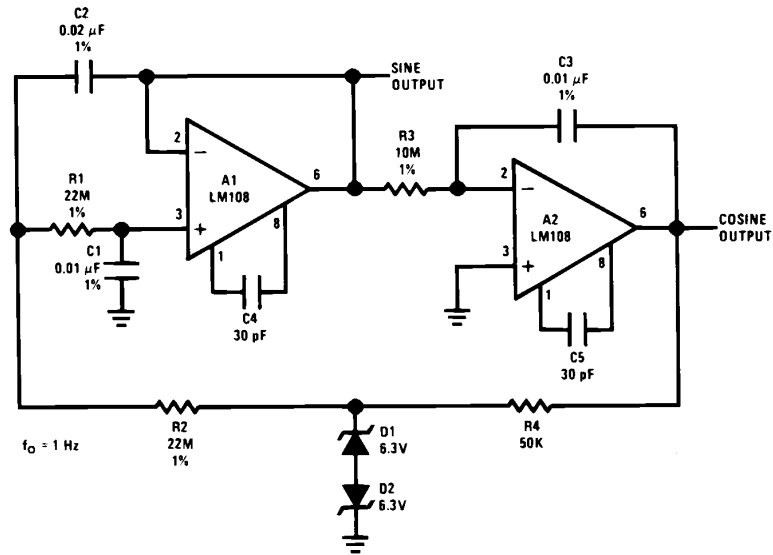


Offset Voltage Adjustment for Inverting Amplifiers Using 10 kΩ Source Resistance or Less



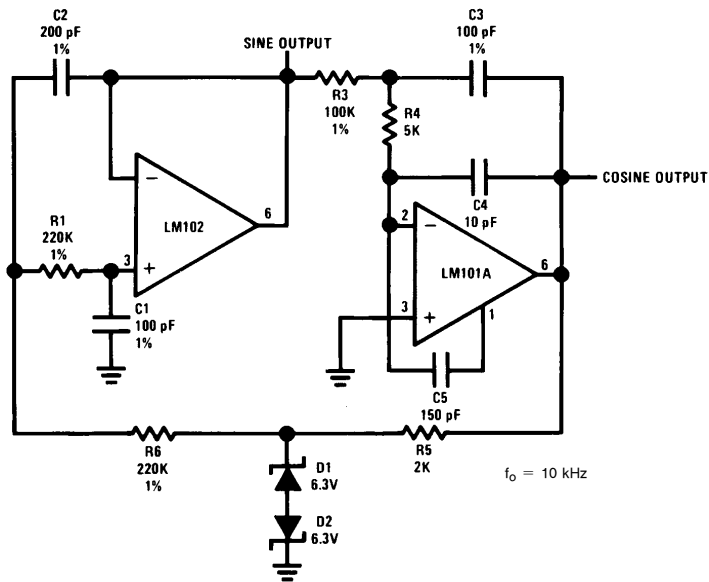
SECTION 2 — SIGNAL GENERATION

Low Frequency Sine Wave Generator with Quadrature Output

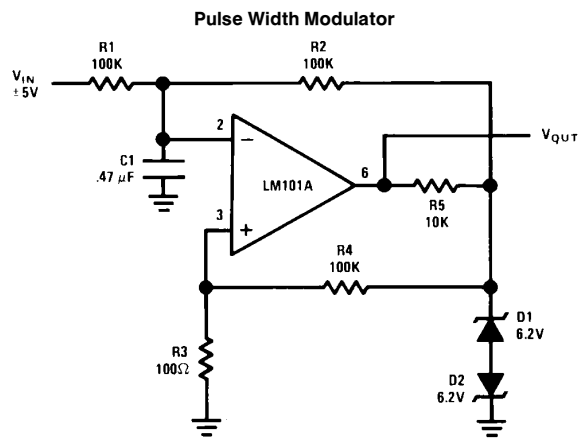
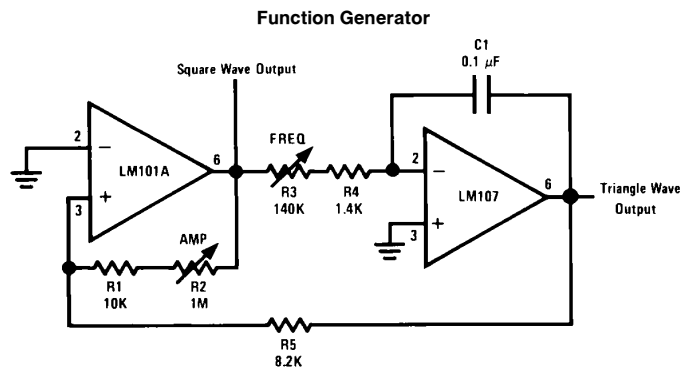
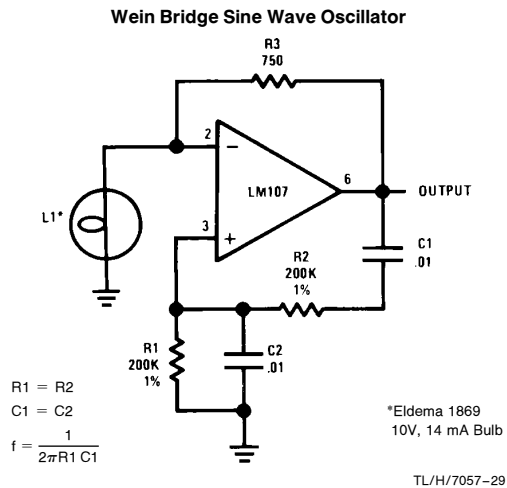
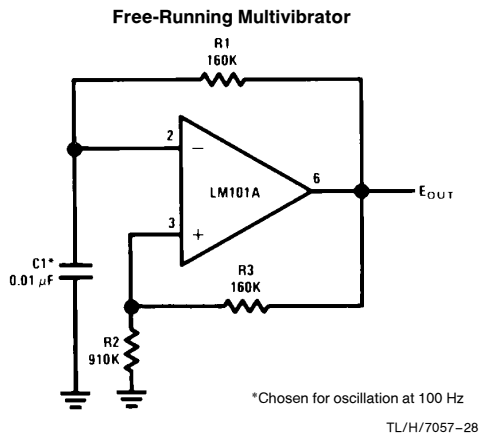


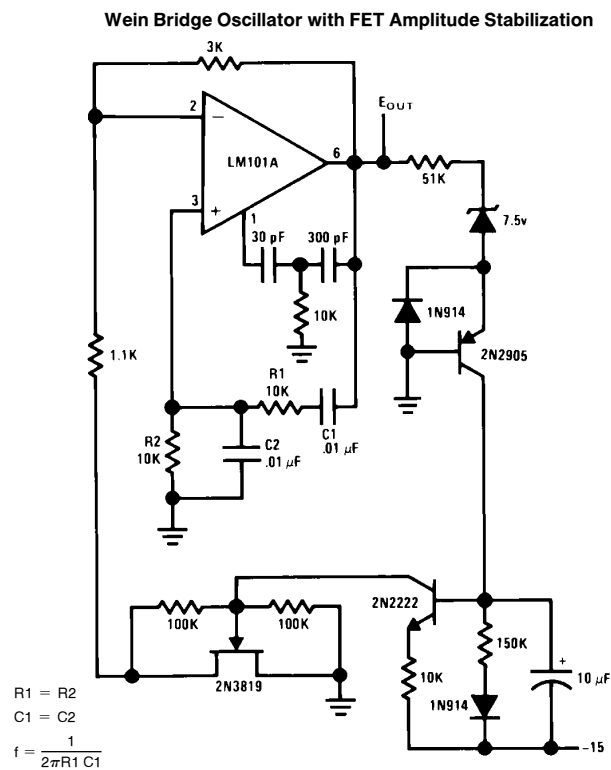
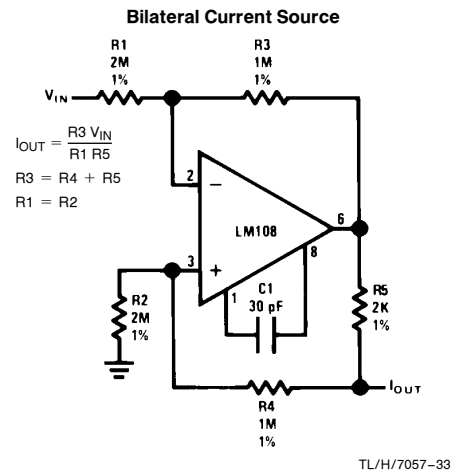
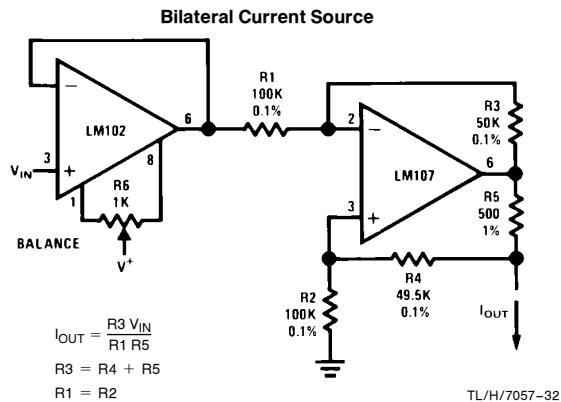
TL/H/7057-26

High Frequency Sine Wave Generator with Quadrature Output

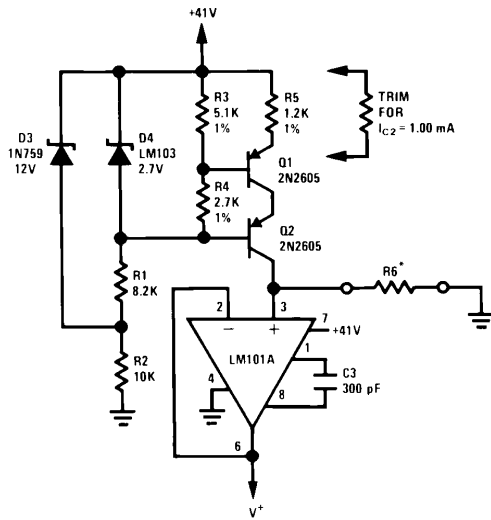


TL/H/7057-27

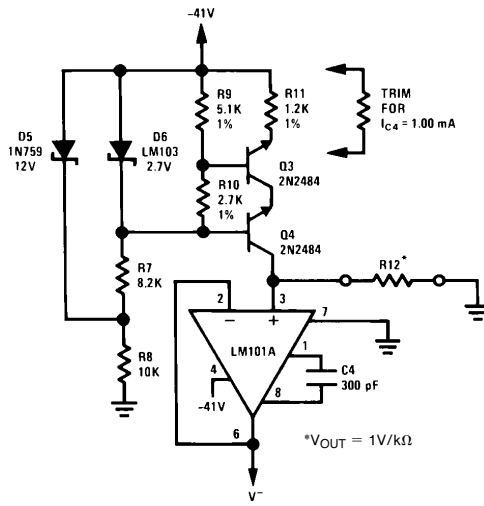




Low Power Supply for Integrated Circuit Testing

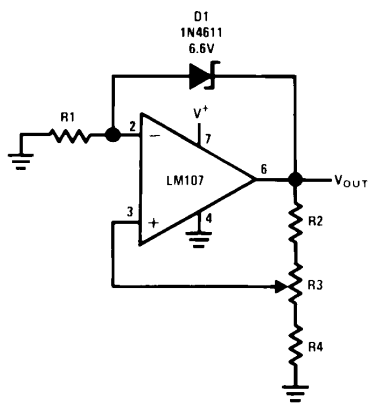


TL/H/7057-35



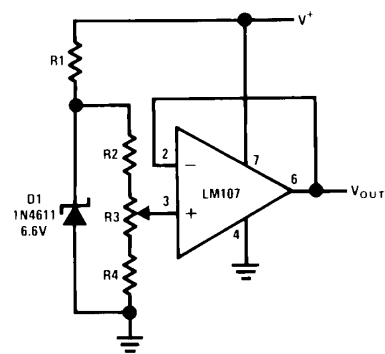
TL/H/7057-91

Positive Voltage Reference



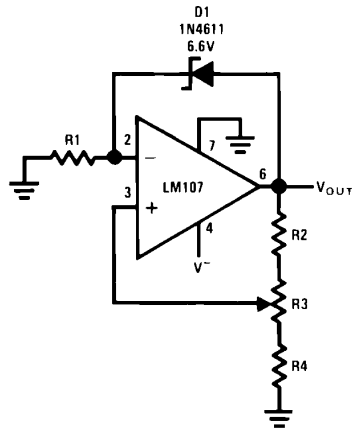
TL/H/7057-36

Positive Voltage Reference



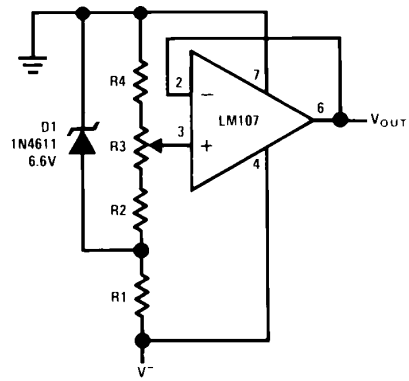
TL/H/7057-37

Negative Voltage Reference



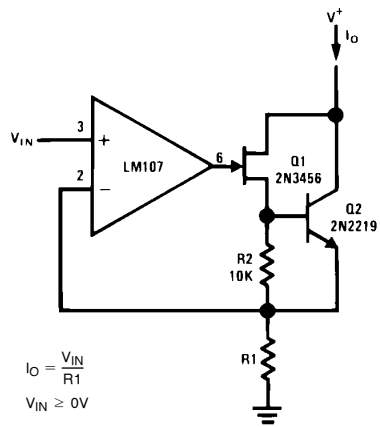
TL/H/7057-38

Negative Voltage Reference



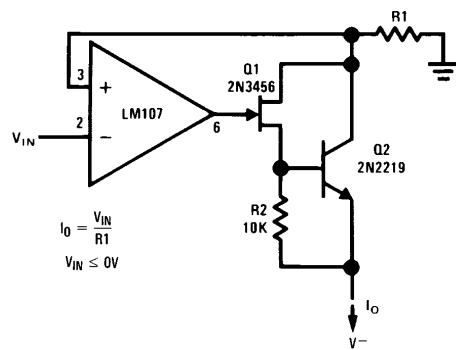
TL/H/7057-39

Precision Current Sink



TL/H/7057-40

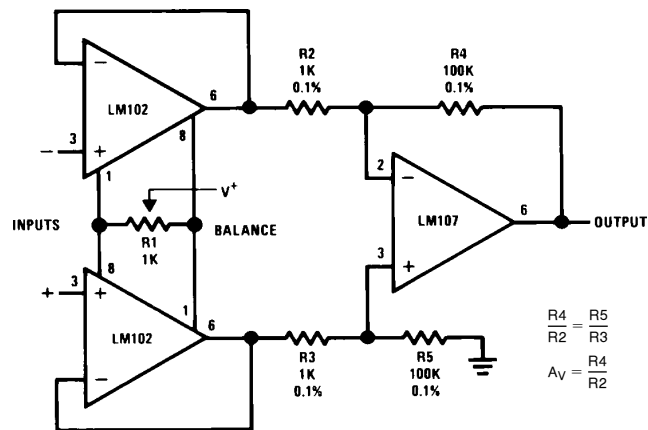
Precision Current Source



TL/H/7057-41

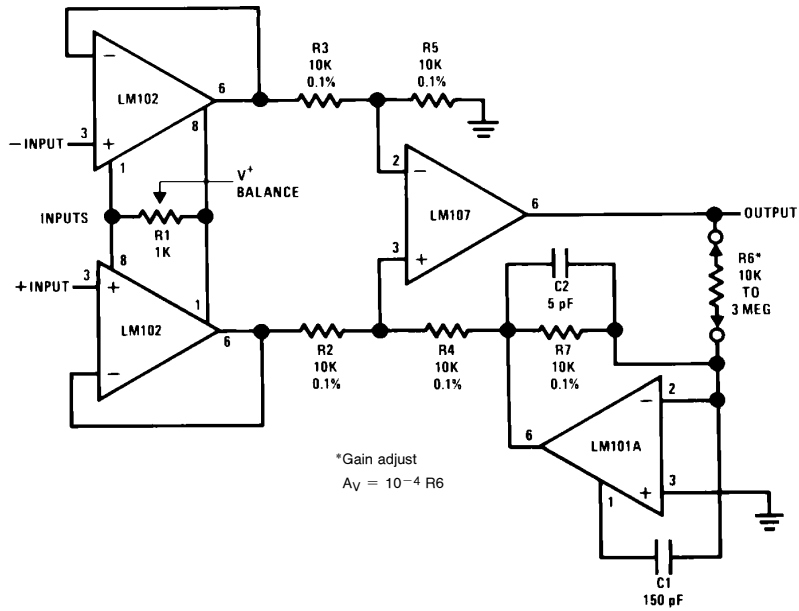
SECTION 3 — SIGNAL PROCESSING

Differential-Input Instrumentation Amplifier



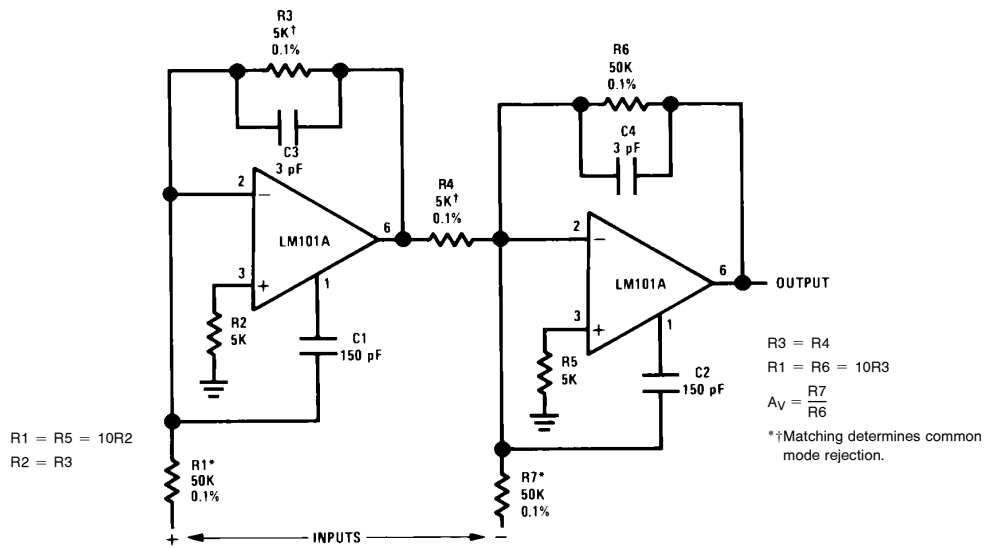
TL/H/7057-42

Variable Gain, Differential-Input Instrumentation Amplifier



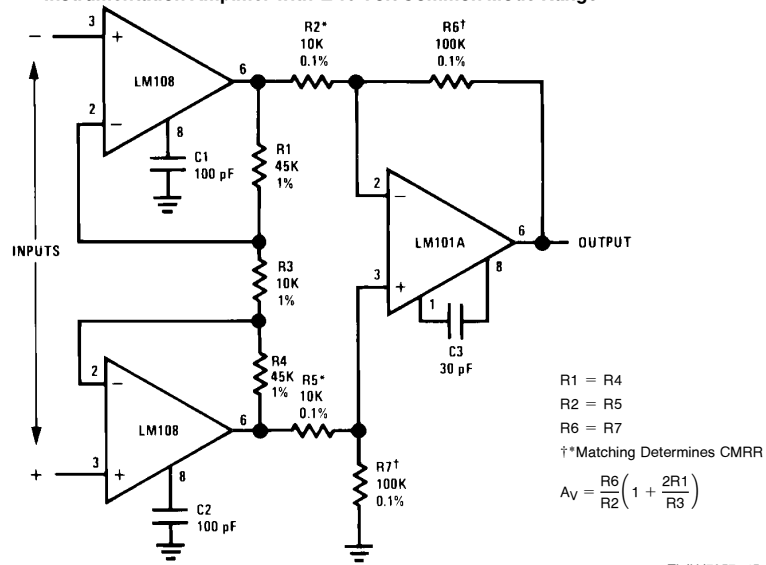
TL/H/7057-43

Instrumentation Amplifier with ± 100 Volt Common Mode Range



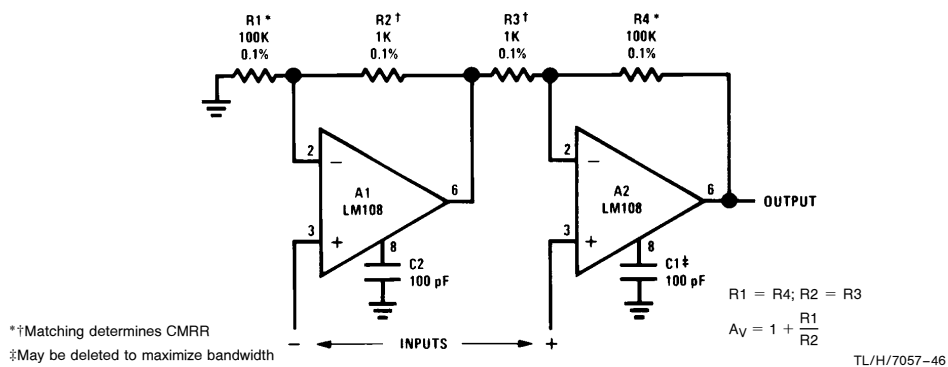
TL/H/7057-44

Instrumentation Amplifier with ± 10 Volt Common Mode Range



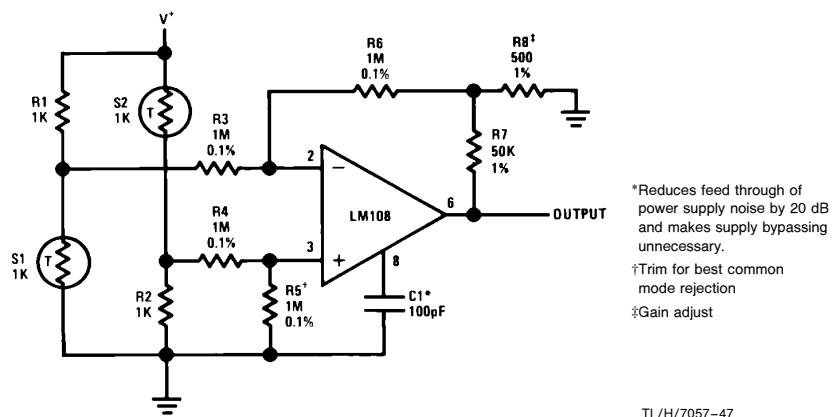
TL/H/7057-45

High Input Impedance Instrumentation Amplifier

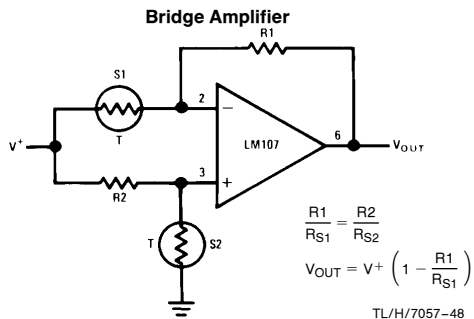


TL/H/7057-46

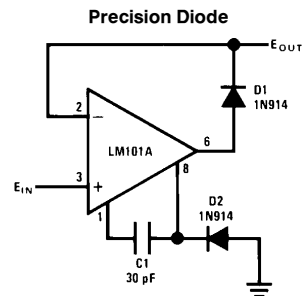
Bridge Amplifier with Low Noise Compensation



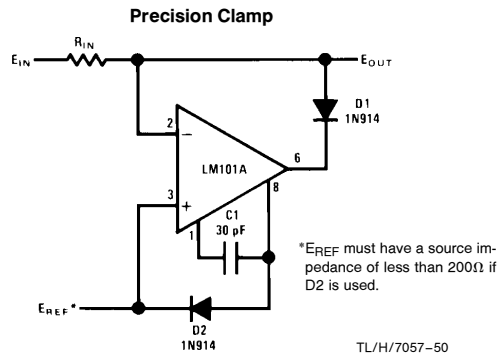
TL/H/7057-47



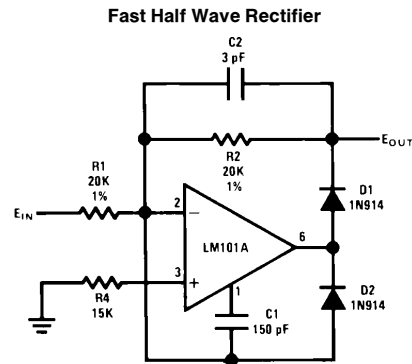
TL/H/7057-48



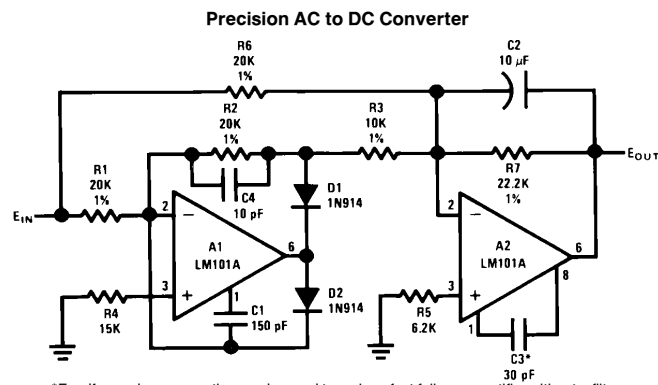
TL/H/7057-49



TL/H/7057-50

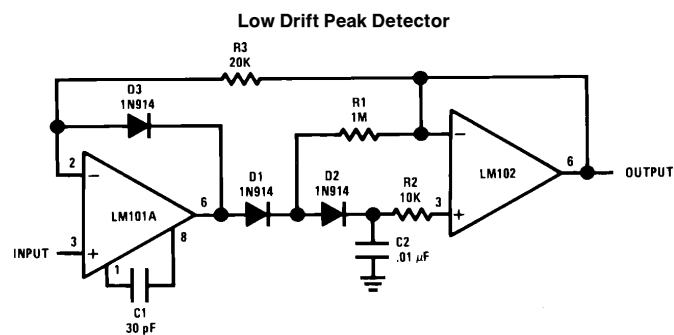


TL/H/7057-51



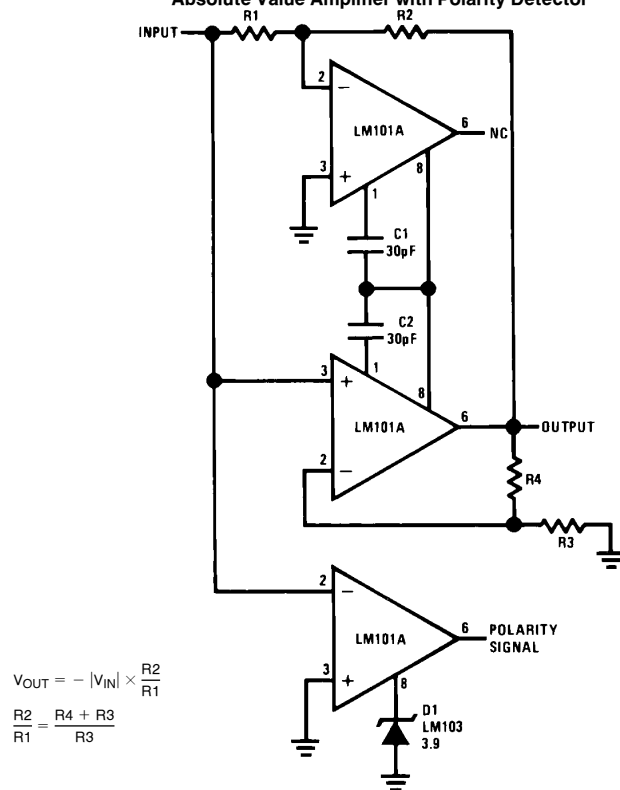
*Feedforward compensation can be used to make a fast full wave rectifier without a filter.

TL/H/7057-52



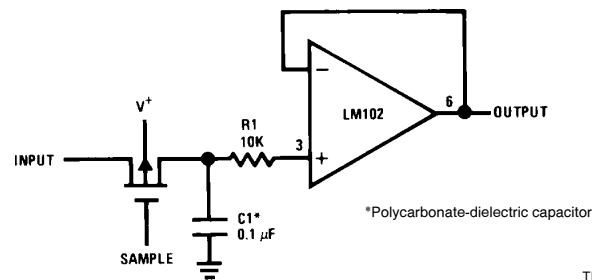
TL/H/7057-53

Absolute Value Amplifier with Polarity Detector



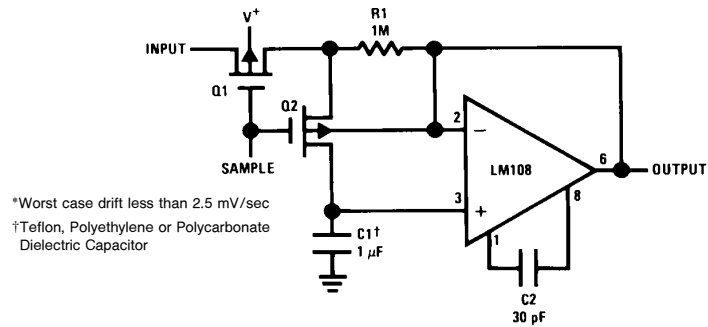
TL/H/7057-54

Sample and Hold



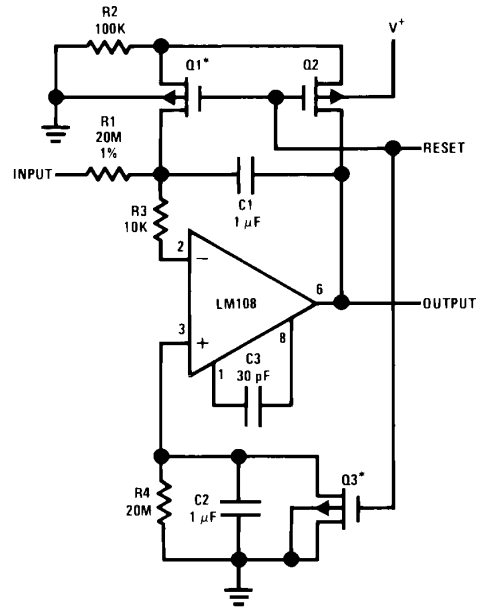
TL/H/7057-55

Sample and Hold



TL/H/7057-56

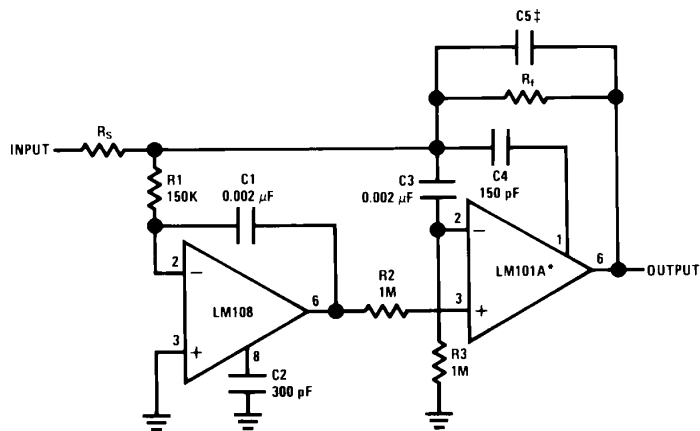
Low Drift Integrator



*Q1 and Q3 should not have internal gate-protection diodes.

TL/H/7057-57
Worst case drift less than 500 $\mu\text{V}/\text{sec}$ over -55°C to $+125^\circ\text{C}$.

Fast[†] Summing Amplifier with Low Input Current



* In addition to increasing speed, the LM101A raises high and low frequency gain, increases output drive capability and eliminates thermal feedback.

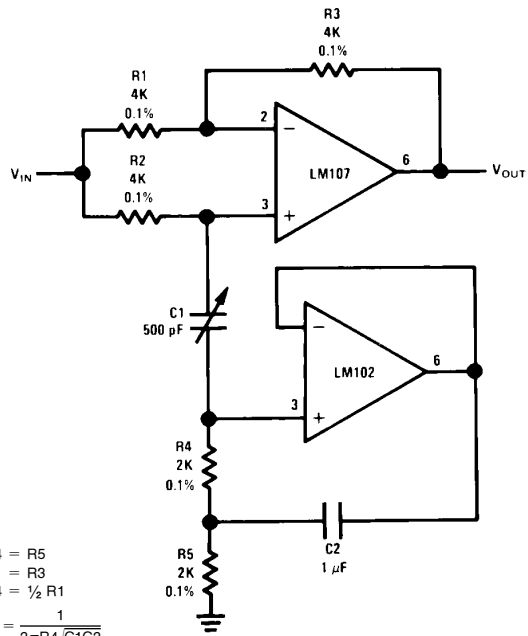
† Power Bandwidth: 250 kHz
Small Signal Bandwidth: 3.5 MHz
Slew Rate: 10V/ μs

$$\ddagger C5 = \frac{6 \times 10^{-8}}{R_f}$$

TL/H/7057-58

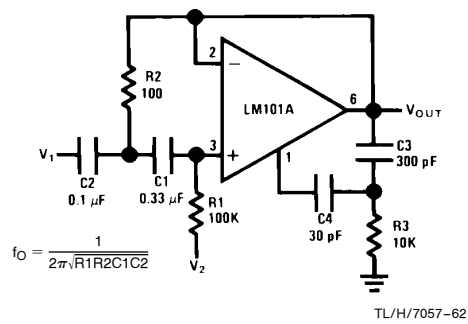
[illegible]
$$f_0 = \frac{1}{2\pi R_1 C_1}$$
$$= 60 \text{ Hz}$$
$$R_1 = R_2 = R_3$$
$$C_1 = C_2 = C_{23}$$

Easily Tuned Notch Filter

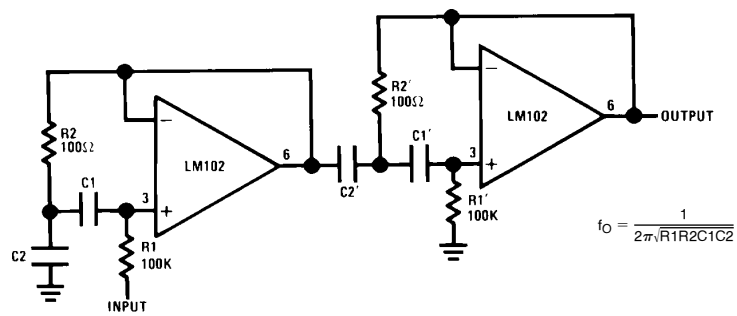


TL/H/7057-61

Tuned Circuit

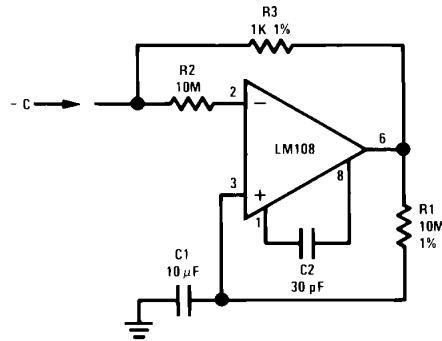


Two-Stage Tuned Circuit



TL/H/7057-63

Negative Capacitance Multiplier



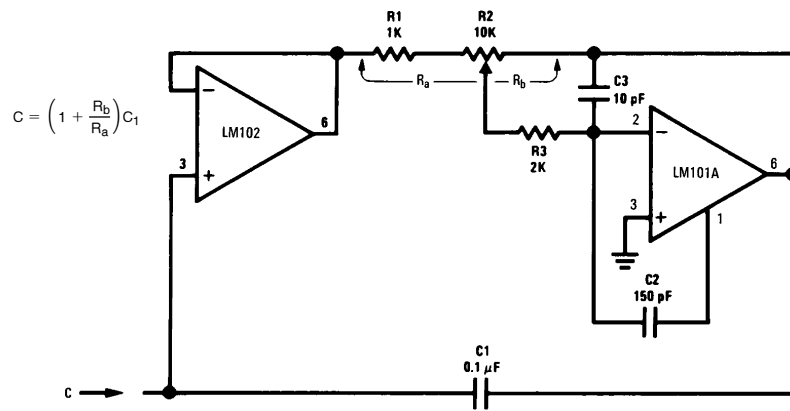
$$C = \frac{R_2}{R_3} C_1$$

$$I_L = \frac{V_{os} + R_2 I_{os}}{R_3}$$

$$R_S = \frac{R_3(R_1 + R_{IN})}{R_{IN} A_{VO}}$$

TL/H/7057-65

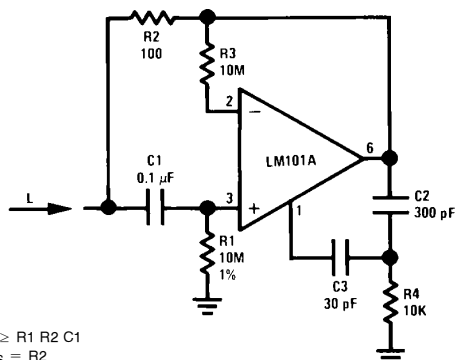
Variable Capacitance Multiplier



$$C = \left(1 + \frac{R_b}{R_a}\right) C_1$$

TL/H/7057-66

Simulated Inductor



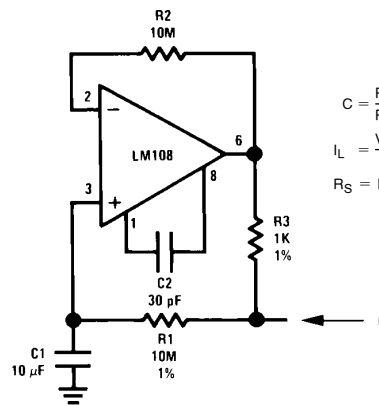
$$L \geq R_1 R_2 C_1$$

$$R_S = R_2$$

$$R_P = R_1$$

TL/H/7057-67

Capacitance Multiplier



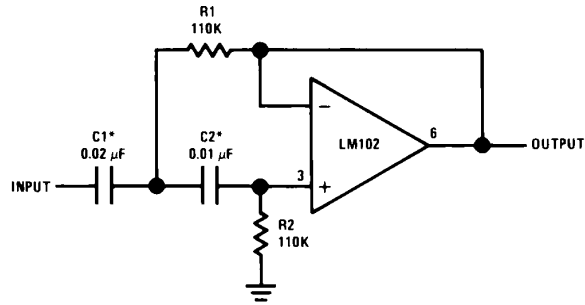
$$C = \frac{R_1}{R_3} C_1$$

$$I_L = \frac{V_{os} + I_{os} R_1}{R_3}$$

$$R_S = R_3$$

TL/H/7057-68

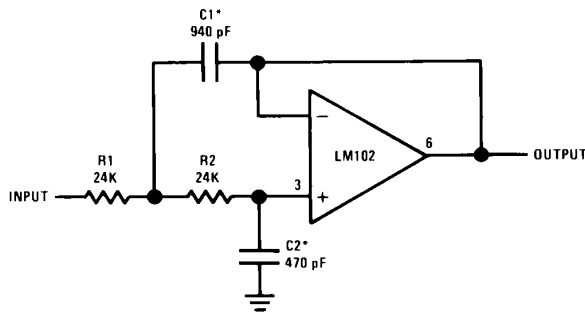
High Pass Active Filter



TL/H/7057-71

*Values are for 100 Hz cutoff. Use metallized polycarbonate capacitors for good temperature stability.

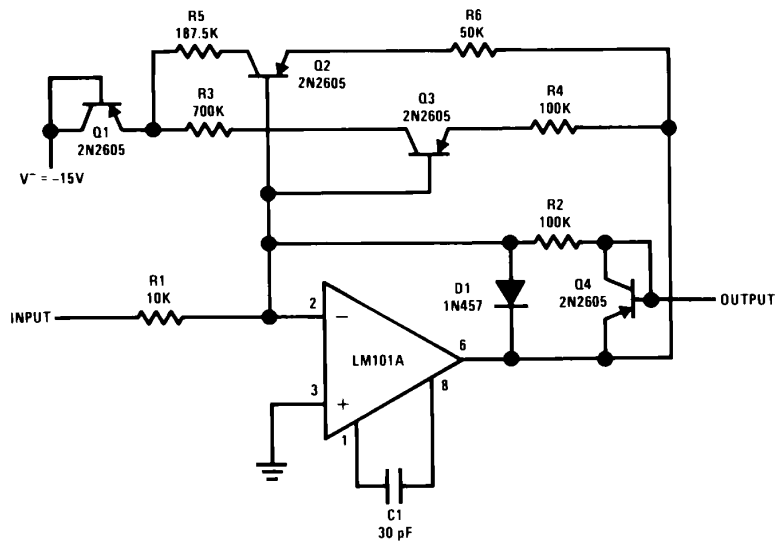
Low Pass Active Filter



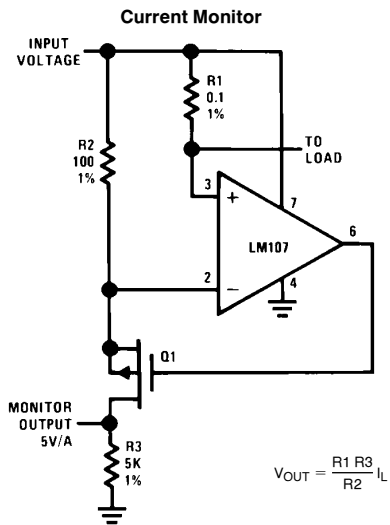
TL/H/7057-72

*Values are for 10 kHz cutoff. Use silvered mica capacitors for good temperature stability.

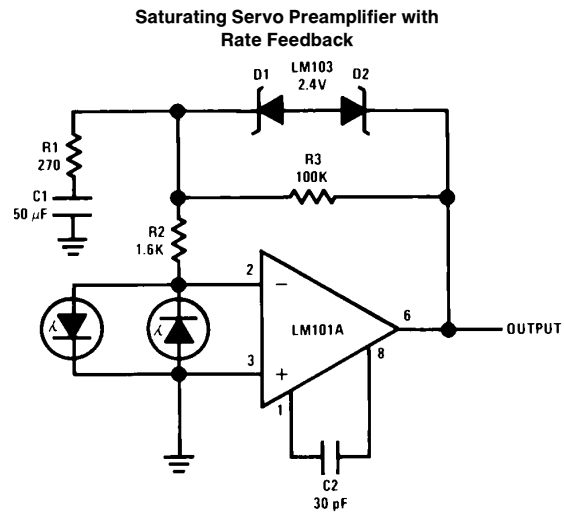
Nonlinear Operational Amplifier with Temperature Compensated Breakpoints



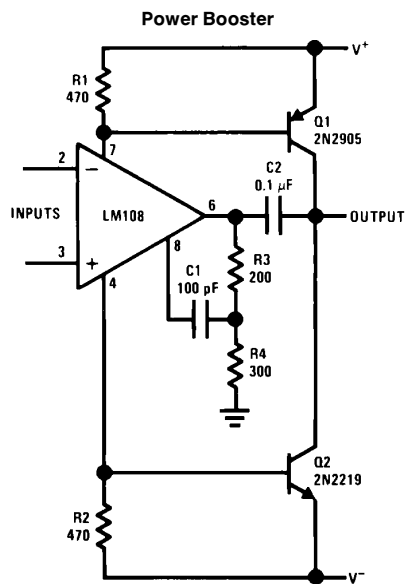
TL/H/7057-73



TL/H/7057-74

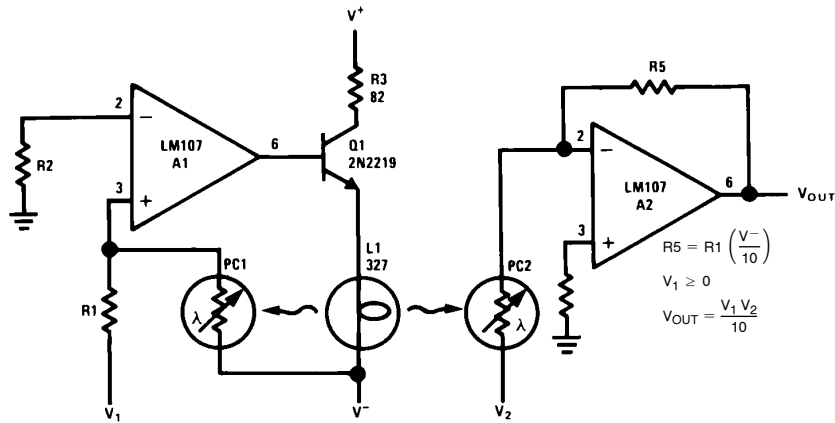


TL/H/7057-75



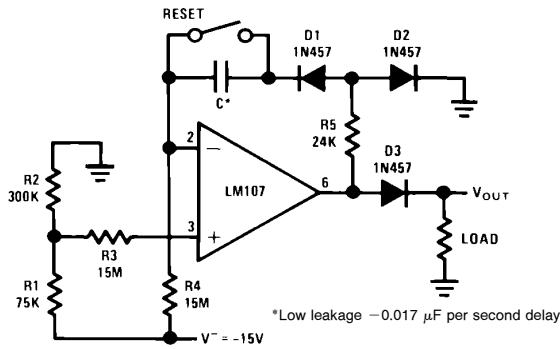
TL/H/7057-76

Analog Multiplier



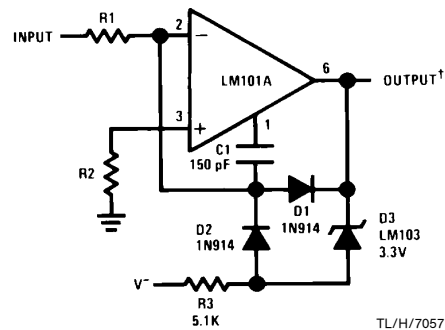
TL/H/7057-77

Long Interval Timer



TL/H/7057-78

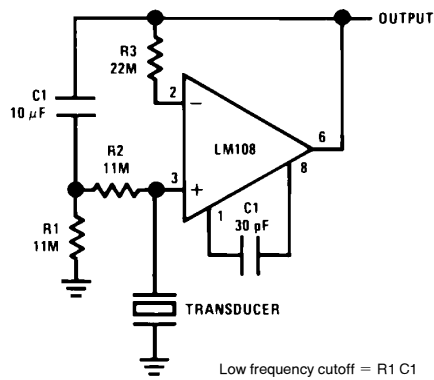
Fast Zero Crossing Detector



TL/H/7057-79

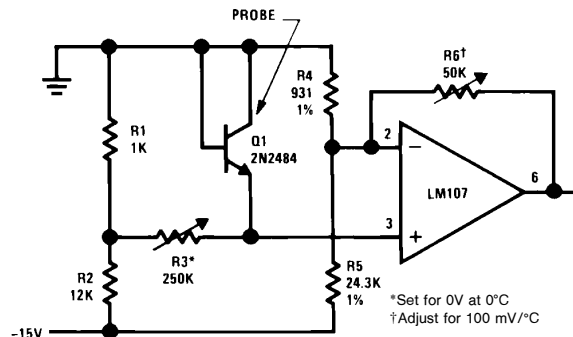
Propagation delay approximately 200 ns
 †DTL or TTL fanout of three.
 Minimize stray capacitance
 Pin 8

Amplifier for Piezoelectric Transducer



TL/H/7057-80

Temperature Probe



TL/H/7057-81

*Operating photodiode with less than 3 mV across it eliminates leakage currents.

The circuit diagram shows a precision current source. An input voltage V_{IN} is applied through a resistor R_S to the non-inverting input of op-amp A1 (LM108). The inverting input of A1 is connected to its output through a feedback capacitor C_1 (300 pF). The output of A1 is connected to the base of transistor Q1 (2N2920). The emitter of Q1 is grounded. The collector of Q1 is connected to the non-inverting input of op-amp A2 (LM101A). The inverting input of A2 is connected to its output through a feedback capacitor C_3 (20 pF). The output of A2 is connected to the base of transistor Q2 (2N2920). The emitter of Q2 is connected to ground through a resistor R_1 (15.7 k Ω , 1% tolerance). The collector of Q2 is connected to a positive supply $V^+ = 15V$ through a resistor R_3 (1.5 M Ω , 1% tolerance). The output of the circuit is taken from the collector of Q2, which is also connected to ground through a resistor R_4 (1.5 M Ω). A temperature sensor S_1 (1 k Ω , $+0.3\%/^{\circ}C$) is connected between the emitters of Q1 and Q2. Compensation capacitors C_2 (300 pF) and C_4 (150 pF) are connected between the inputs and outputs of A1 and A2, respectively.

$V^+ = 15V$

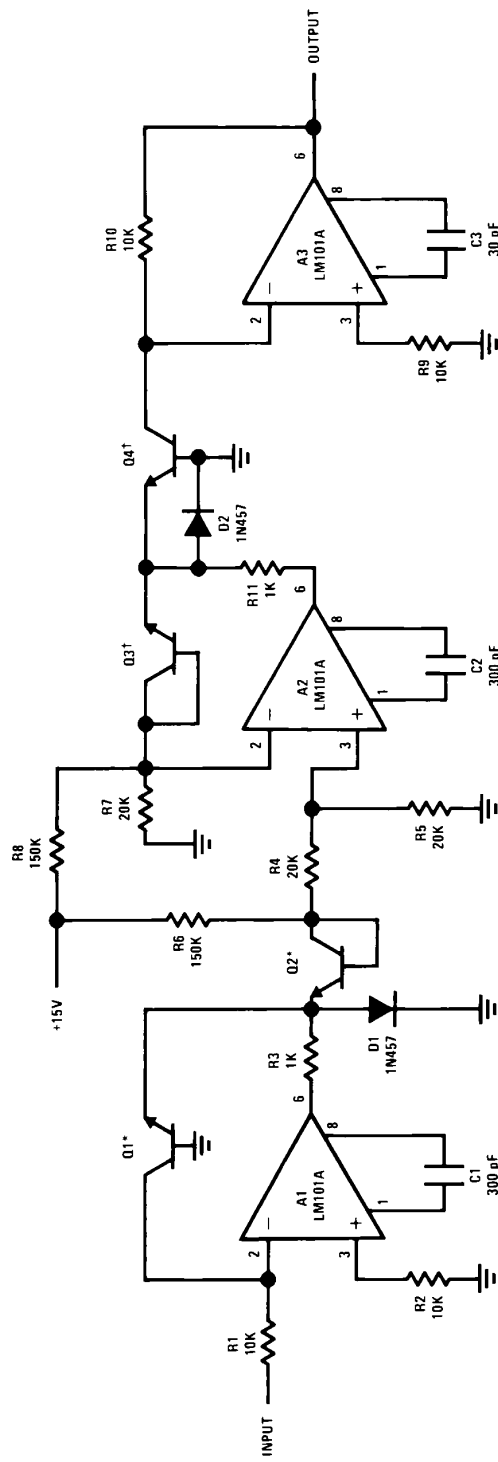
$R_3^* 1.5M 1\%$

$\dagger 1\text{ k}\Omega (\pm 1\% \text{ at } 25^{\circ}C, +3500\text{ ppm}/^{\circ}C.$
Available from Vishay Ultronic,
Grand Junction, CO, Q81 Series.

*Determines current for zero
crossing on output: $10\text{ }\mu A$
as shown.

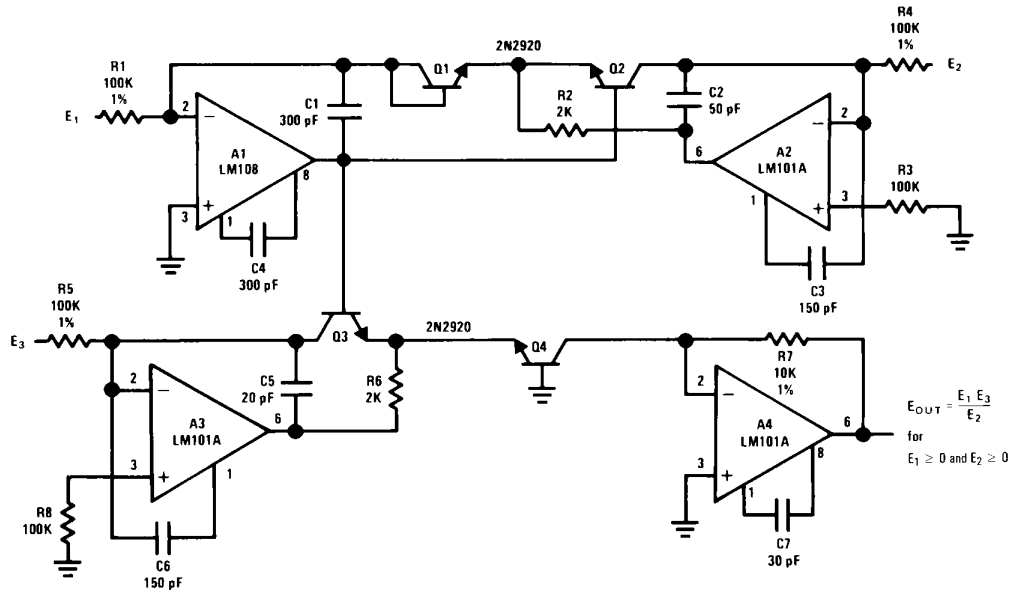
10 nA < I_{IN} < 1 mA
Sensitivity is 1V per decade

Root Extractor



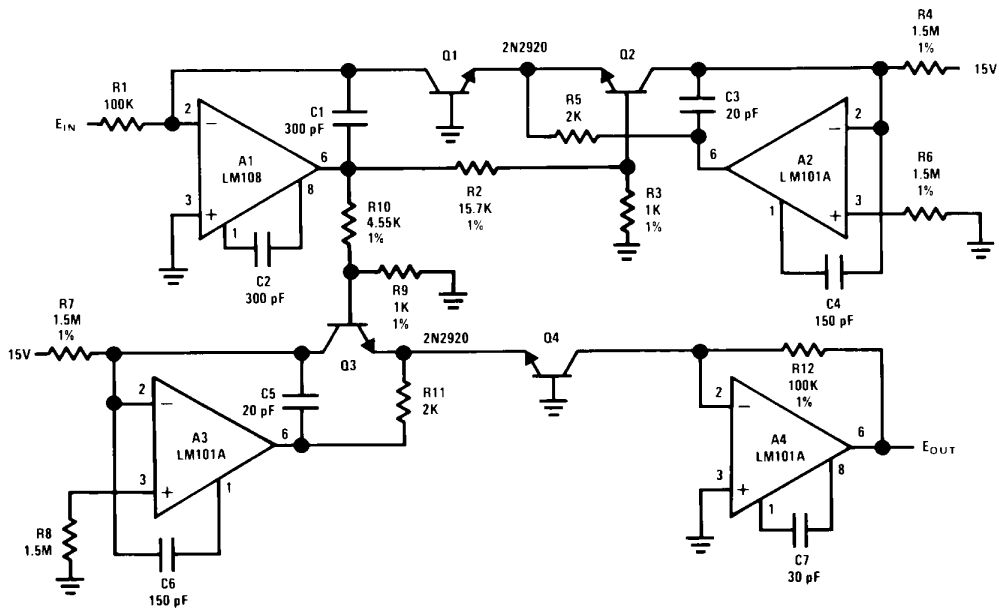
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Multiplier/Divider



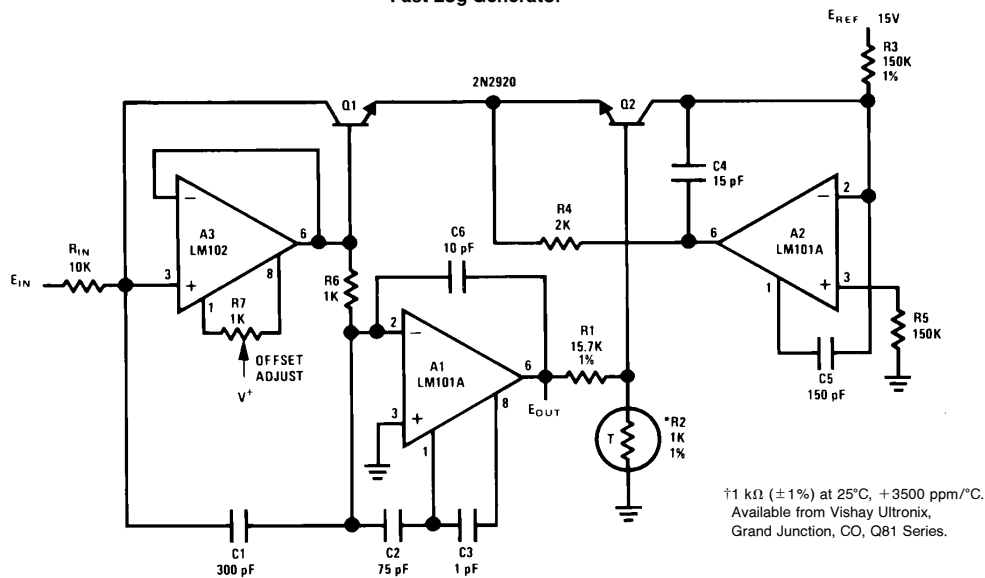
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Cube Generator



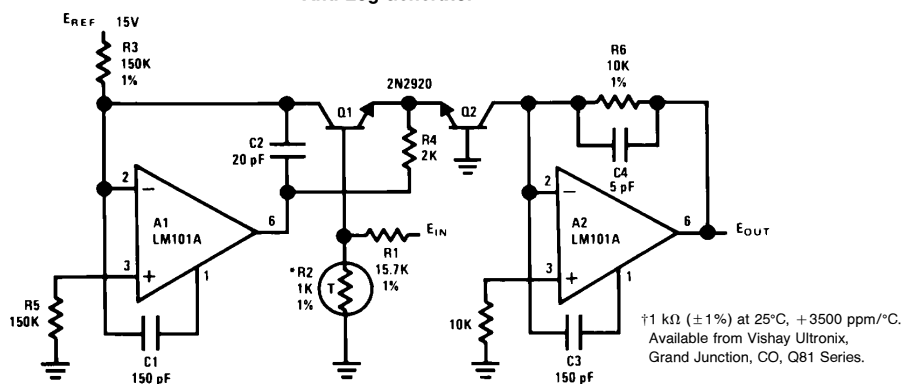
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Fast Log Generator



TL/H/7057-89

Anti-Log Generator



TL/H/7057-90

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